

Enhancement Mode P-Channel Power MOSFET

 $TO-252/PMOS/-30V/\pm20V/-1.6V/-80A/6.0m\Omega$

Rev1.1





-30V, 6.0mΩ, -80A, Single P-Channel

1.Features

- ◆ 100% EAS Guaranteed
- ◆ Green Device Available
- ◆ Super Low Gate Charge
- ◆ Excellent Cdv/dt effect decline
- ◆ Advanced high cell density Trench technology

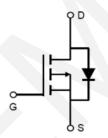
V _{DS}	R _{DS(on)} Typ.	I _D Max.
-30V	6.0mΩ @ -10V	004
	9.0mΩ @ -4.5V	-80A

2.Applications

◆ Load Switching



Pin Description



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP30P80	WP30P80	TO-252	2,500	25,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{ extsf{DSS}}$	-30	V
Gate to Source Voltage	V_{GSS}	±20	V
Drain Current (DC)	I _D	-80	А
Drain Current (Pulse), PW≤300µs	I _{DP}	-175	А
Total Dissipation	P _D	31.2	W
Avalanche Energy, Single Pulsed	E _{AS}	31	mJ
Junction Temperature	Tj	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit	
Junction to case	R _{eJC}	4	°C/W	
Junction to Ambient	$R_{ heta JA}$	43	°C/W	

Note 2: When mounted on 1 inch square copper board t ≤ 10sec The value in any given application depends on the user's specific board design.

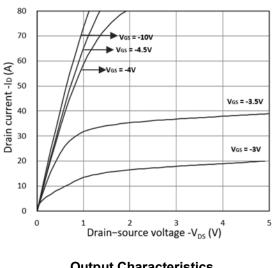
6.Electrical Characteristics at Ta=25°C (Note 3)

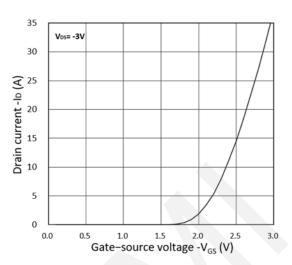
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = -250 \mu A, V_{GS} = 0 V$	-30		-	V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = -24V, V _{GS} = 0V	ı	1	-1	μA
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V, V_{SS} = 0V$,	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =-250μA	-1.0	-1.6	-2.5	V
Static Drain to Source On-State	R _{DS(on)}	I _D = -12A, V _{GS} = -10V	-	6	8.8	mΩ
Resistance	25(6)	I _D = -8A, V _{GS} = -4.5V	-	9	14	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,	-	4320	-	pF
Output Capacitance	C _{oss}	V _{DS} =-15V,	-	529	-	pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz	-	487	-	pF
Turn-ON Delay Time	t _{d(on)}	$V_{DS} = -15V, I_{D} = -15A$ $V_{GS} = -10V,$ $R_{G} = 2.5\Omega$	-	18.9	-	ns
Rise Time	t _r		-	15.7	-	ns
Turn-OFF Delay Time	$t_{d(off)}$		-	64.8	-	ns
Fall Time	t _f		-	36.5	-	ns
	Q_g	V _{DS} = -15V,	-	45	-	nC
Total Gate Charge	Q_{gs}	V _{GS} =-10V,	-	8.5	-	nC
	Q_{gd}	I _D = -15A	-	12.8	-	nC
Diode Forward Voltage	V_{FSD}	I _S =-1A, V _{GS} = 0V	-	-	-1	V

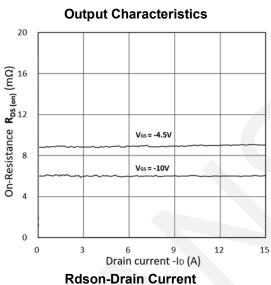
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

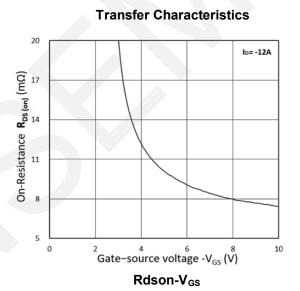


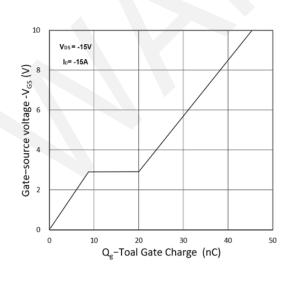
7. Typical electrical and thermal characteristics

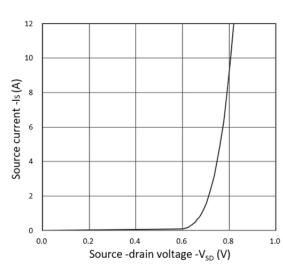








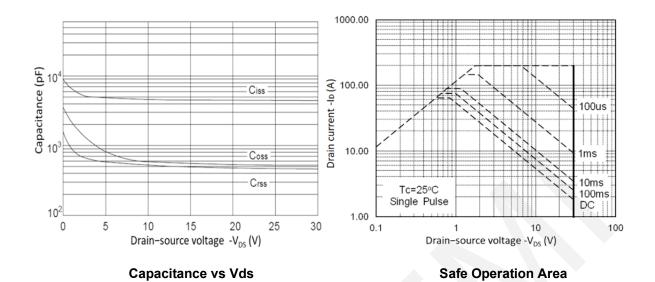




Gate Charge

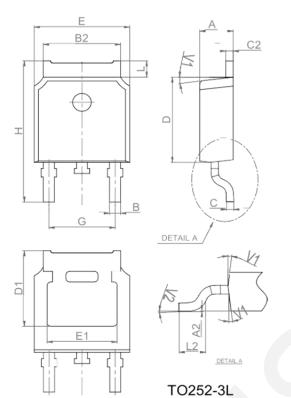
Source-Drain Voltage







8.Package Dimensions



	Dimensions						
Ref.	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
Α	2.10		2.50	0.083		0.098	
A2	0		0.10	0		0.004	
В	0.66		0.86	0.026		0.034	
B2	5.18		5.48	0.202		0.216	
С	0.40		0.60	0.016		0.024	
C2	0.44		0.58	0.017		0.023	
D	5.90		6.30	0.232		0.248	
D1	5.30REF			0.209REF			
E	6.40		6.80	0.252		0.268	
E1	4.63			0.182			
G	4.47		4.67	0.176		0.184	
Н	9.50		10.70	0.374		0.421	
L	1.09		1.21	0.043		0.048	
L2	1.35		1.65	0.053		0.065	
V1		7°			7°		
V2	0°		6°	0°		6°	



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